

<b>Notice of References Cited</b>	Application/Control No. 10/659,830	Applicant(s)/Patent Under Reexamination CHMAYTELLI ET AL.	
	Examiner Sonny TRINH	Art Unit 2687	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0266392	12-2004	Jiddou, Nada S.	455/406
	B	US-6,044,258	03-2000	Abdella, Richard Michael	455/405
	C	US-6,208,851	03-2001	Hanson, Daniel A.	455/405
	D	US-6,704,563	03-2004	Senn et al.	455/406
	E	US-6,532,282	03-2003	Plush et al.	379/114.03
	F	US-2004/0148638	07-2004	Weisman et al.	725/115
	G	US-6,912,382	06-2005	Fellenstein et al.	455/405
	H	US-5,826,185	10-1998	Wise et al.	455/405
	I	US-6,785,561	08-2004	Kim, Jong-Kwang	455/566
	J	US-6,725,056	04-2004	Moles et al.	455/524
	K	US-6,014,561	01-2000	Molne, Anders Lennart	455/419
	L	US-5,754,953	05-1998	Briancon et al.	455/418
	M	US-5,854,978	12-1998	Heidari, Alireza Ryan	455/418

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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